PTO/SB/08A (08-00)

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Substitute for form 1449A/PTO				Complete if Known			
				Application Number	Not Known 10705454		
INFO	PRMATION	DISCL	.OSURE 🦼	Filing Date	11/10/2003		
STA	TEMENT B	Y APP	LICANT()	First Named Inventor	Silver et al.		
				Group Art Unit	2625		
	(use as many shee	ets as nece	ssary)	Examiner Name	D. Mariam		
Sheet	1	of	('3)	Attorney Docket Number	C97-050 CON5		

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	-				U.S. PATENT DOCUMEN	TS	
Examin Initials*		Cite No.1	U.S. Patent Doc	ument Kind Code ² (il known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Crs. 11 SAL Figures Appear
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Examiner Initials*	Cite No.1	Office	Foreign Patent Docu Number ⁴	ment Kind Code ⁵ (il known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevent Passages or Relevant Figures Appear	7
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Substitute for form 1449B/PTO				Comp	Complete if Known		
				Application Number	Not Known		
INFO	PRMATIO	N DISC	LOSURE	Filing Date	11/10/2003		
STA	TEMENT	BY APF	PLICANT	First Named Inventor	Silver, et al.		
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Sheet	2	of	()3)	Attorney Docket Number	C97-050 CON5		

Examiner 1	Cite	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the	T				
Initials*	No.	item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	י				
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	Application Number	Not Known	
INFORMATION DISCLOSURE	Filing Date	11/10/2003	
STATEMENT BY APPLICANT,	First Named Inventor	Silver et al.	
1 L	Group Art Unit	2625	
(use as many sheets as necessary)	Examiner Name	D. Mariam	
Sheet 3 of (3)	Attorney Docket Number	C97-050_CON5	

OTHER PRIOR	ART -	NON PATENT LITERATURE DOCUMENTS				
Examiner Initials*	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²			
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